

ABSTRACT OF THE DISCLOSURE

A prober for measuring the electrical characteristics of a test target object includes a tester, stage, probe card, first sensor, second sensor,
5 and controller. The stage places a test target object thereon. The test target object has a plurality of electrical circuit devices on its surface. Each of the electrical circuit devices has a plurality of electrodes on its surface. The probe card is arranged
10 above the stage. The probe has a plurality of probes. The probes are connected to the tester. The first sensor detects the positions of distal ends of the probes. The second sensor detects the surface position of an individual one of the electrical circuit devices.
15 The controller brings the probes of the probe card and the electrodes of the electrical circuit devices into contact with each other.